

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/561,613	<b>Applicant(s)/Patent under Reexamination</b> STUER ET AL.
	<b>Examiner</b> Jennifer Y. Cho	<b>Art Unit</b> 1621

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC Search	5/9/2007	JD
Inventor Search	5/9/2007	JD
East Search	6/5/2007	JC
Inventor Search	6/6/2007	JC